Application/Control No. Applicant(s)/Patent Under Reexamination 10/088,789 BAITZ ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2876 Seung H. Lee **U.S. PATENT DOCUMENTS Document Number** Date Classification Name · Country Code-Number-Kind Code MM-YYYY 235/381 US-5,939,694 08-1999 Holcomb et al. Α * 05-2000 Wike et al. 235/462.43 US-6,062,477 В US-С US-D US-Ε US-F US-G US-Н USı US-US-Κ US-US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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